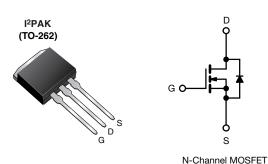
www.vishay.com

Vishay Siliconix

Power MOSFET



PRODUCT SUMMARY				
V _{DS} (V)	500			
R _{DS(on)} (Ω)	$V_{GS} = 10 \text{ V}$	0.55		
Q _g (Max.) (nC)	51			
Q _{gs} (nC)	12			
Q _{gd} (nC)	23			
Configuration	Single			

FEATURES

- Dynamic dV/dt rating
- · Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- · Simple drive requirements
- Material categorization: for definitions of compliance please see www.vishay.com/doc?99912

This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation Power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

ORDERING INFORMATION	
Package	I ² PAK (TO-262)
Lead (Pb)-free	IRFSL11N50APbF

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	500	V	
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Current	V _{GS} at 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		11		
Continuous Drain Current	V _{GS} at 10 V	T _C = 100 °C	I _D	7.0	Α	
Pulsed Drain Current ^a			I _{DM}	44		
Linear Derating Factor				1.3	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	390	mJ	
Repetitive Avalanche Currenta			I _{AR}	11	Α	
Repetitive Avalanche Energy ^a			E _{AR}	19	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	190	W	
Peak Diode Recovery dV/dt ^c			dV/dt	4.1	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 175	°C	
Soldering Recommendations (Peak Temperature) for 10 s				300 ^d		

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11) b. Starting T_J = 25 °C, L = 6.4 mH, R_G = 25 Ω , I_{AS} = 11 A (see fig. 12)
- c. $I_{SD} \le 11$ Å, $dI/dt \le 185$ Å/µs, $V_{DD} \le V_{DS}$, $T_{J} \le 175$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER SYMBOL TYP. MAX. UNIT					
Maximum Junction-to-Ambient	R _{thJA}	-	40	°C/W	
Maximum Junction-to-Case (Drain)	R _{thJC}	-	0.75	C/VV	

PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$, $I_D = 250 \mu A$		500	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference	ce to 25 °C, I _D = 1 mA	-	0.57	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	V _{DS} =	= V _{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	,	$V_{GS} = \pm 30 \text{ V}$	ı	1	± 100	nA
Zero Gate Voltage Drain Current	less	V _{DS} =	= 500 V, V _{GS} = 0 V	ı	-	25	μА
Zero date voltage Drain ourient	I _{DSS}	V _{DS} = 400 V	/, V _{GS} = 0 V, T _J = 150 °C	-	-	250	
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	$I_D = 6.6 \text{ A}^b$	-	-	0.55	Ω
Forward Transconductance	9 _{fs}	V _{DS} =	= 50 V, I _D = 6.6 A ^b	6.0	-	-	S
Dynamic							
Input Capacitance	C_{iss}		$V_{GS} = 0 \text{ V}$	ı	1426	-	
Output Capacitance	C_{oss}		$V_{DS} = 25 \text{ V}$	ı	208	-	- - pF
Reverse Transfer Capacitance	C_{rss}	T = 1.	.0 MHz, see fig. 5	ı	9.6	-	
Output Capacitance	C		V _{DS} = 1.0 V, f = 1.0 MHz	1	1954	-	
Output Capacitance	C_{oss}	$V_{GS} = 0 V$	V _{GS} = 0 V V _{DS} = 400 V, f = 1.0 MHz		53	-	
Effective Output Capacitance	Coss eff.		V _{DS} = 0 V to 400 V ^c		110	-	
Total Gate Charge	Qg			-	-	51	
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V		-	-	12	nC
Gate-Drain Charge	Q_{gd}]		-	-	23	
Turn-On Delay Time	t _{d(on)}			-	14	-	
Rise Time	t _r	V _{DD} = 250 V, I _D = 11 A		-	34	-	
Turn-Off Delay Time	t _{d(off)}	$R_G = 9.1 \Omega$, $R_D = 22 \Omega$, see fig. 10^b	-	32	-	ns
Fall Time	t _f	1		-	27	-	
Internal Drain Inductance	L _D	Between lead 6 mm (0.25")	from	-	4.5	-	ml l
Internal Source Inductance	L _S	package and die contact	center of	-	7.5	-	- nH
Drain-Source Body Diode Characteristic	cs						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	11	А
Pulsed Diode Forward Current ^a	I _{SM}			-	-	44	
Body Diode Voltage	V_{SD}	$T_J = 25 ^{\circ}C$	C , $I_S = 11 A$, $V_{GS} = 0 V^b$	-	1	1.5	V
Body Diode Reverse Recovery Time	t _{rr}	T 25 °C 1	_F = 11 A, dl/dt = 100 A/μs ^b	ı	530	790	ns
Body Diode Reverse Recovery Charge	Q _{rr}	1J = 25 C, I	- = 11 A, αί/αι = 100 A/μS	-	3.4	5.1	μC
Forward Turn-On Time	t _{on}	Intrinsic tu	on is dor	ninated b	y L _S and	L _D)	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11) b. Pulse width $\leq 300~\mu s$; duty cycle $\leq 2~\%$ c. C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 % to 80% V_{DS}



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

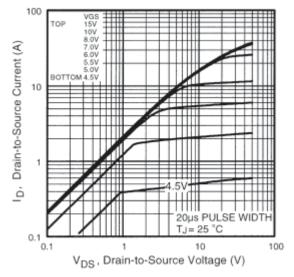


Fig. 1 - Typical Output Characteristics

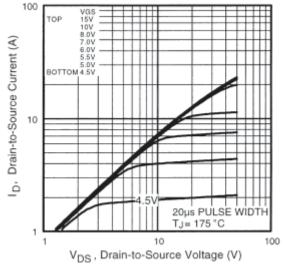


Fig. 2 - Typical Output Characteristics

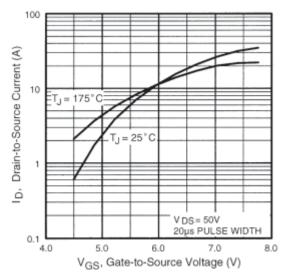


Fig. 3 - Typical Transfer Characteristics

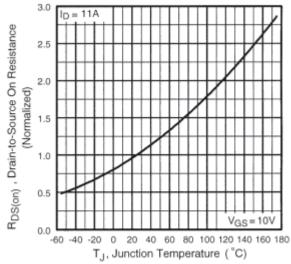


Fig. 4 - Normalized On-Resistance vs. Temperature



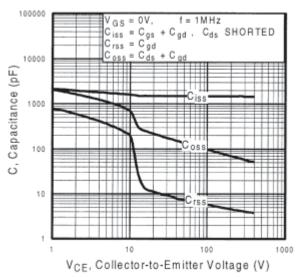


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

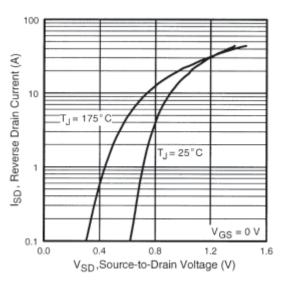


Fig. 7 - Typical Source-Drain Diode Forward Voltage

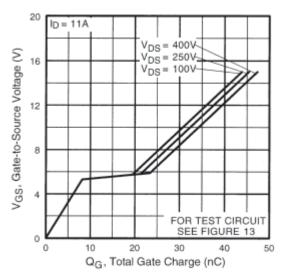


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

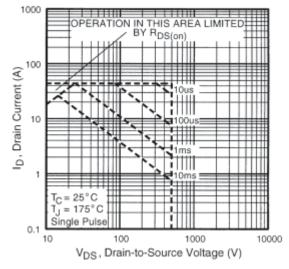


Fig. 8 - Maximum Safe Operating Area



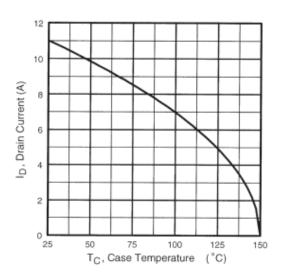


Fig. 8 - Maximum Drain Current vs. Case Temperature

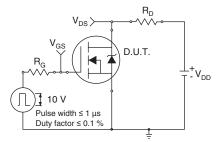


Fig. 9a - Switching Time Test Circuit

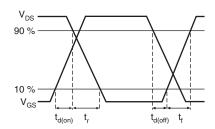


Fig. 10b - Switching Time Waveforms

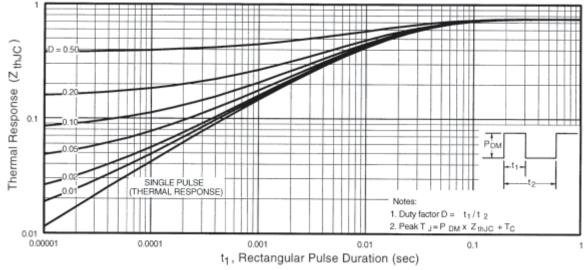


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case



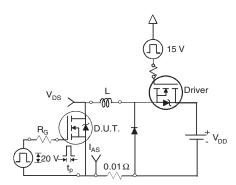


Fig. 12a - Unclamped Inductive Test Circuit

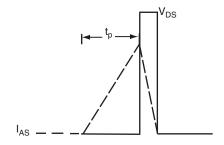


Fig. 12b - Unclamped Inductive Waveforms

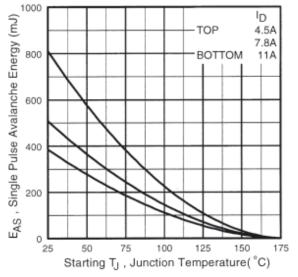


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

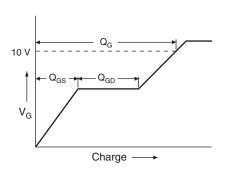


Fig. 13a - Basic Gate Charge Waveform

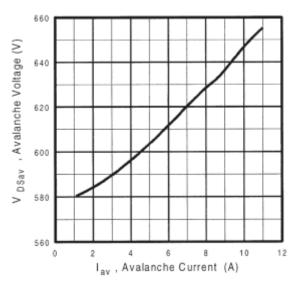


Fig. 12d - Typical Drain-to-Source Voltage vs.
Avalanche Current

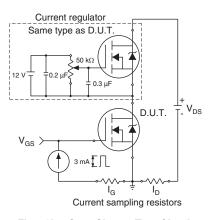
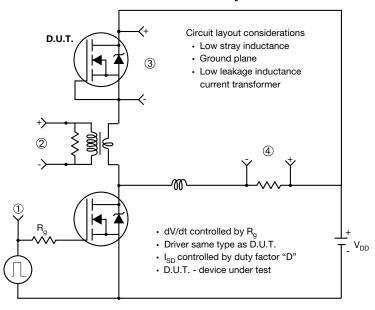


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



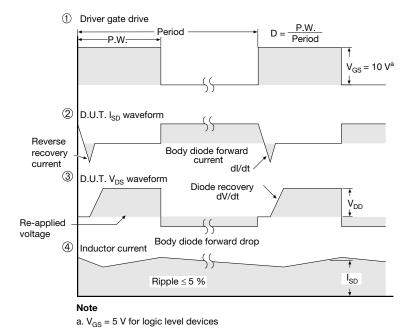


Fig. 14 - For N-Channel

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TO-263AB (HIGH VOLTAGE)







	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	0.00	0.25	0.000	0.010
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065
D	8.38	9.65	0.330	0.380

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	i
е	2.54	BSC	0.100 BSC	
Н	14.61	15.88	0.575	0.625
L	1.78	2.79	0.070	0.110
L1	-	1.65	ı	0.066
L2	-	1.78	i	0.070
L3	0.25 BSC		0.010	BSC
L4	4.78	5.28	0.188	0.208

DWG: 5970

Notes

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimensions are shown in millimeters (inches).

ECN: S-82110-Rev. A, 15-Sep-08

- 3. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm (0.005") per side. These dimensions are measured at the outmost extremes of the plastic body at datum A.
- 4. Thermal PAD contour optional within dimension E, L1, D1 and E1.
- 5. Dimension b1 and c1 apply to base metal only.
- 6. Datum A and B to be determined at datum plane H.
- 7. Outline conforms to JEDEC outline to TO-263AB.

Document Number: 91364 www.vishay.com Revision: 15-Sep-08





I²PAK (TO-262) (HIGH VOLTAGE)



	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
Α	4.06	4.83	0.160	0.190
A1	2.03	3.02	0.080	0.119
b	0.51	0.99	0.020	0.039
b1	0.51	0.89	0.020	0.035
b2	1.14	1.78	0.045	0.070
b3	1.14	1.73	0.045	0.068
С	0.38	0.74	0.015	0.029
c1	0.38	0.58	0.015	0.023
c2	1.14	1.65	0.045	0.065

	MILLIMETERS		INC	HES
DIM.	MIN.	MAX.	MIN.	MAX.
D	8.38	9.65	0.330	0.380
D1	6.86	-	0.270	-
E	9.65	10.67	0.380	0.420
E1	6.22	-	0.245	-
е	2.54	BSC	0.100	BSC
L	13.46	14.10	0.530	0.555
L1	-	1.65	-	0.065
L2	3.56	3.71	0.140	0.146

Scale: None

ECN: S-82442-Rev. A, 27-Oct-08 DWG: 5977

- 1. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 2. Dimension D and E do not include mold flash. Mold flash shall not exceed 0.127 mm per side. These dimensions are measured at the outmost extremes of the plastic body.
- 3. Thermal pad contour optional within dimension E, L1, D1, and E1.
- 4. Dimension b1 and c1 apply to base metal only.

Document Number: 91367 Revision: 27-Oct-08





RECOMMENDED MINIMUM PADS FOR D²PAK: 3-Lead



Recommended Minimum Pads Dimensions in Inches/(mm)

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